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1:8 LVDS 1.8V / 2.5V Fanout Buffer for 1PPS and High-Speed Clocks

8P34S1208 Datasheet

Description

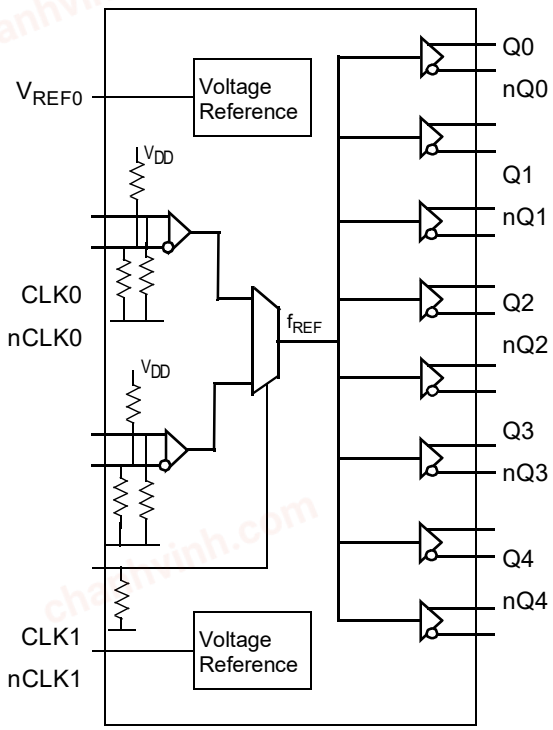
The 8P34S1208 is a high-performance differential LVDS fanout buffer. The device is designed for the fanout of 1PPS signals or high-frequency, very low additive phase-noise clock and data signals.

The 8P34S1208 is characterized to operate from a 1.8V or 2.5V power supply. Guaranteed output-to-output and part-to-part skew characteristics make the 8P34S1208 ideal for those clock distribution applications demanding well-defined performance and repeatability. Two selectable differential inputs and eight low skew outputs are available. The integrated bias voltage reference enables easy interfacing of single-ended signals to the device inputs. The device is optimized for low power consumption and low additive phase noise.

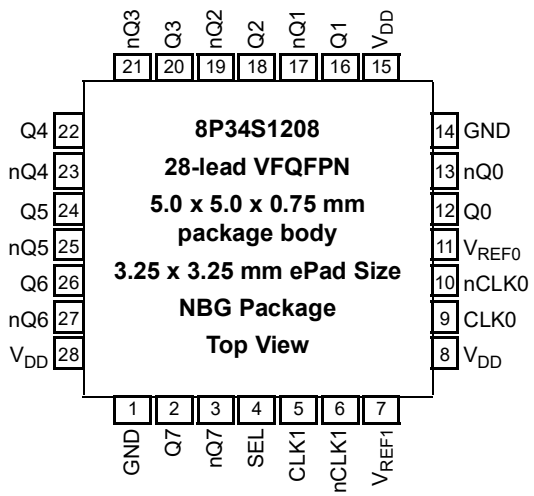
Features

- Eight low skew, low additive jitter LVDS output pairs
- Two selectable, differential clock input pairs
- Differential CLK, nCLK pairs can accept the following differential input levels: LVDS, CML
- Maximum input clock frequency: 1.5GHz
- LVCMOS/LVTTL interface levels for the control input select pin
- Output skew: 20ps (typical)
- Propagation delay: 400ps (maximum)
- Low propagation delay variation across temperature for 1PPS applications
- Low additive phase jitter, RMS; f_{REF} = 156.25MHz, V_{PP} = 1V, 12kHz–20MHz: 34fs (typical)
- Device current consumption (I_{DD}):
  - 120mA typical: 1.8V
  - 132mA typical: 2.5V
- Full 1.8V or 2.5V supply voltage
- Lead-free (RoHS 6), 28-Lead VFQFPN packaging
- -40°C to +85°C ambient operating temperature
- Supports case temperature up to +105°C
- Supports PCI Express Gen 1-5

Block Diagram



Pin Assignment



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Pin Description and Pin Characteristic Tables

Table 1. Pin Descriptions[a]

Number	Name	Type		Description
1, 14	GND	Power		Power supply pin.
2, 3	Q7, nQ7	Output		Differential output pair 7. LVDS interface levels.
4	SEL	Input	Pulldown	Reference select control pin. See Table 3 for function. LVCMOS/LVTTL interface levels.
5	CLK1	Input	Pulldown	Non-inverting differential clock/data input 1.
6	nCLK1	Input	Pullup/ Pulldown	Inverting differential clock/data input 1. $V_{DD}/2$ default when left floating.
7	V_{REF1}	Output		Bias voltage reference. Provides an input bias voltage for the CLK1, nCLK1 input pair in AC-coupled applications. Refer to *Figures 2B and 2C* for applicable AC-coupled input interfaces.
8, 15, 28	V_{DD}	Power		Power supply pin.
9	CLK0	Input	Pulldown	Non-inverting differential clock/data input 0.
10	nCLK0	Input	Pullup/ Pulldown	Inverting differential clock/data input 0. $V_{DD}/2$ default when left floating.
11	V_{REF0}	Output		Bias voltage reference. Provides an input bias voltage for the CLK0, nCLK0 input pair in AC-coupled applications. Refer to *Figures 2B and 2C* for applicable AC-coupled input interfaces.
12, 13	Q0, nQ0	Output		Differential output pair 0. LVDS interface levels.
16, 17	Q1, nQ1	Output		Differential output pair 1. LVDS interface levels.
18, 19	Q2, nQ2	Output		Differential output pair 2. LVDS interface levels.
20, 21	Q3, nQ3	Output		Differential output pair 3. LVDS interface levels.
22, 23	Q4, nQ4	Output		Differential output pair 4. LVDS interface levels.
24, 25	Q5, nQ5	Output		Differential output pair 5. LVDS interface levels.
26, 27	Q6, nQ6	Output		Differential output pair 6. LVDS interface levels.

[a] *Pulldown* and *Pullup* refers to an internal input resistors. See Table 2, *Pin Characteristics,* for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C_{IN}	Input Capacitance			2		pF
$R_{PULLDOWN}$	Input Pulldown Resistor			51		kΩ
R_{PULLUP}	Input Pullup Resistor			51		kΩ

Table 3. SEL Input Function Table[a]

Input SEL	Operation
0	CLK0, nCLK0 is the selected differential clock input.
1	CLK1, nCLK1 is the selected differential clock input.

[a] SEL is an asynchronous control.

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Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V_{DD}	4.6V
Inputs, V_I	-0.5V to V_{DD} + 0.5V
Outputs, I_O Continuous Current Surge Current	 10mA 15mA
Input Sink/Source, I_{REF}	±2mA
Maximum Junction Temperature, $T_{J,MAX}$	125°C
Storage Temperature, T_{STG}	-65°C to 150°C
ESD - Human Body Model, NOTE 1	2000V
ESD - Charged Device Model, NOTE 1	1500V

NOTE 1: According to JEDEC JS-001-2012/JESD22-C101E.

DC Electrical Characteristics

Table 4. Power Supply DC Characteristics, V_{DD} = 1.8V ±5%, T_A = -40°C to +85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Power Supply Voltage		1.71	1.8	1.89	V
I_{DD}	Power Supply Current	Q0 to Q3 terminated 100Ω between nQx, Qx		120	140	mA

Table 5. Power Supply DC Characteristics, V_{DD} = 2.1V – 2.7V, T_A = -40°C to +85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Power Supply Voltage		2.1	2.5	2.7	V
I_{DD}	Power Supply Current	Q0 to Q3 terminated 100Ω between nQx, Qx		132	142	mA

Table 6. LVCMOS/LVTTL DC Characteristics, V_{DD} = 1.8V ±5%, 2.1V – 2.7V, T_A = -40°C to +85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage			0.65 * V_{DD}		V_{DD} + 0.3	V
V_{IL}	Input Low Voltage, Note 1			-0.3		0.35 * V_{DD}	V
I_{IH}	Input High Current	SEL	V_{DD} = V_{IN} = 1.89V, 2.7V			150	µA
I_{IL}	Input Low Current	SEL	V_{DD} = 1.89V, 2.7V, V_{IN} = 0V	-10			µA

Note 1: VIL should not be less than -0.3V and VIH should not be higher than V_{DD}.

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Table 7. Differential Inputs Characteristics, V_{DD} = 1.8V ±5%, 2.1V – 2.7V, T_A = -40°C to +85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
I_{IH}	Input High Current	CLK0, nCLK0, CLK1, nCLK1	V_{IN} = V_{DD} = 1.89V, 2.7V			150	µA
I_{IL}	Input Low Current	CLK0, CLK1	V_{IN} = 0V, V_{DD} = 1.89V, 2.7V	-10			µA
		nCLK0, nCLK1	V_{IN} = 0V, V_{DD} = 1.89V, 2.7V	-150			µA
V_{REF}	Reference Voltage for Input Bias[a] Note3.		I_{REF} = +100µA, V_{DD} = 1.8V, 2.5V	0.9		1.30	V
V_{PP}	Peak-to-Peak Voltage		V_{DD} = 1.89V, 2.7V	0.2		1.0	V
V_{CMR}	Common Mode Input Voltage[b] [c]			0.9		V_{DD} – (V_{PP}/2)	V

[a] V_{REF} specification is applicable to the AC-coupled input interfaces shown in *Figures 2B and 2C.*
[b] Common mode input voltage is defined as crosspoint voltage.
[c] V_{IL} should not be less than -0.3V and V_{IH} should not be higher than V_{DD}.

Table 8. LVDS AC and DC Characteristics, V_{DD} = 1.8V ±5%, 2.1V – 2.7V, T_A = -40°C to +85°C **[a]**

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{OD}	Differential Output Voltage	f_{REF} < 1.5GHz, outputs loaded with 100Ω	247		454	mV
V_{OD}	Differential Output Voltage	f_{REF} < 500MHz, outputs loaded with 100Ω	310		454	mV
ΔV_{OD}	V_{OD} Magnitude Change				50	mV
V_{OS}	Offset Voltage	V_{DD} = 1.8V ±5%	1.00		1.40	V
V_{OS}	Offset Voltage	V_{DD} = 2.1V – 2.7V	1.50		2.10	V
ΔV_{OS}	V_{OS} Magnitude Change				50	mV

[a] Output drive current must be sufficient to drive up to 30cm of PCB trace (assume nominal 50Ω impedance).

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AC Electrical Characteristics

Table 9. AC Electrical Characteristics, V_{DD} = 1.8V ±5%, 2.1V – 2.7V, T_A = -40°C to +85° [a]

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
f_{REF}	Input Frequency	CLK[0:1], nCLK[0:1]				1.5	GHz
ΔV/Δt	Input Edge Rate	CLK[0:1], nCLK[0:1]		1.5			V/ns
t_{PD}	Propagation Delay[b]		CLK[0:1]; nCLK[0:1] to any Qx, nQx for V_{PP} = 0.4V	190	315	400	ps
*t*sk(o)	Output Skew[c] [d]				20	40	ps
*t*sk(i)	Input Skew				10	45	ps
*t*sk(p)	Pulse Skew		f_{REF} = 100MHz		6	20	ps
*t*sk(pp)	Part-to-Part Skew[e]					250	ps
t_{JIT}	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter Section		f_{REF} = 156.25MHz; square wave, V_{DD} = 1.8V ± 5%, 2.1V - 2.7V, V_{PP} = 0.5V; Integration range: 1kHz – 40MHz		45	63	fs
			f_{REF} = 156.25MHz square wave, V_{DD} = 1.8V ± 5%, 2.1V – 2.7V, V_{PP} = 1V; Integration range: 12kHz – 20MHz		34	47	fs
t_R / t_F	Output Rise/ Fall Time		10% to 90% outputs loaded with 100Ω		305	400	ps
			20% to 80% outputs loaded with 100Ω		175	260	ps
$MUX_{ISOLATION}$	Mux Isolation[f]		f_{REF} = 100MHz		80		dB

[a] Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

[b] Measured from the differential input crossing point to the differential output crossing point

[c] Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential cross points.

[d] This parameter is defined in accordance with JEDEC Standard 65.

[e] Defined as skew between outputs on different devices operating at the same supply voltage, same frequency, same temperature and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points.

[f] Qx, nQx outputs measured differentially. See *MUX Isolation diagram* in the *Parameter Measurement Information section.*

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Table 10. Characteristics for 1PPS operation, V_{DD} = 1.8V ±5%, 2.1V – 2.7V, T_A = -40°C to +85°C[a] [b] [c] [d]

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
T	Input and Output Pulse Period			1		s
T_P	Positive or Negative Pulse Width		100			ns
t_{PD}	Propagation Delay;	CLKx/nCLKx to Qx/nQx	190		400	ps
tsk(p)	Pulse Skew				20	ps
tsk(i)	Input Skew				45	ps
tsk(o)	Output Skew[e]	Qx/nQx to Qy/nQy			40	ps
tsk(pp)	Part-to-Part Skew[f]				250	ps
t_R / t_F	Output Rise/Fall Time	10% to 90%		305	400	ps

[a] 1PPS (one pulse per second) signals are defined as repetitive pulses with a rate (period) of 1Hz. The positive input pulse width may vary. The active signal edge is the rising edge. Parameters in this table are characterized for a positive input pulse width of 100ns, 100ms and 500ms; All device interfaces are DC-coupled. Parameters are defined in accordance with ITU-T G.703 Amendment 1 - Specifications for the physical layer of the ITU-T G8271/Y.1366 time synchronization interfaces.

[b] Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

[c] t_{PD}, $t_{SK(O)}$, $t_{SK(P)}$ and $t_{SK(P)}$ parameters of differential signals are referenced to the crosspoint.

[d] Differential outputs for 1PPS signal transmission are terminated balanced 100Ω according to the LVDS Output Load Test Circuit figures. The dedicated 1PPS outputs are the differential outputs Q0-Q3.

[e] This parameter is defined in accordance with JEDEC Standard 65.

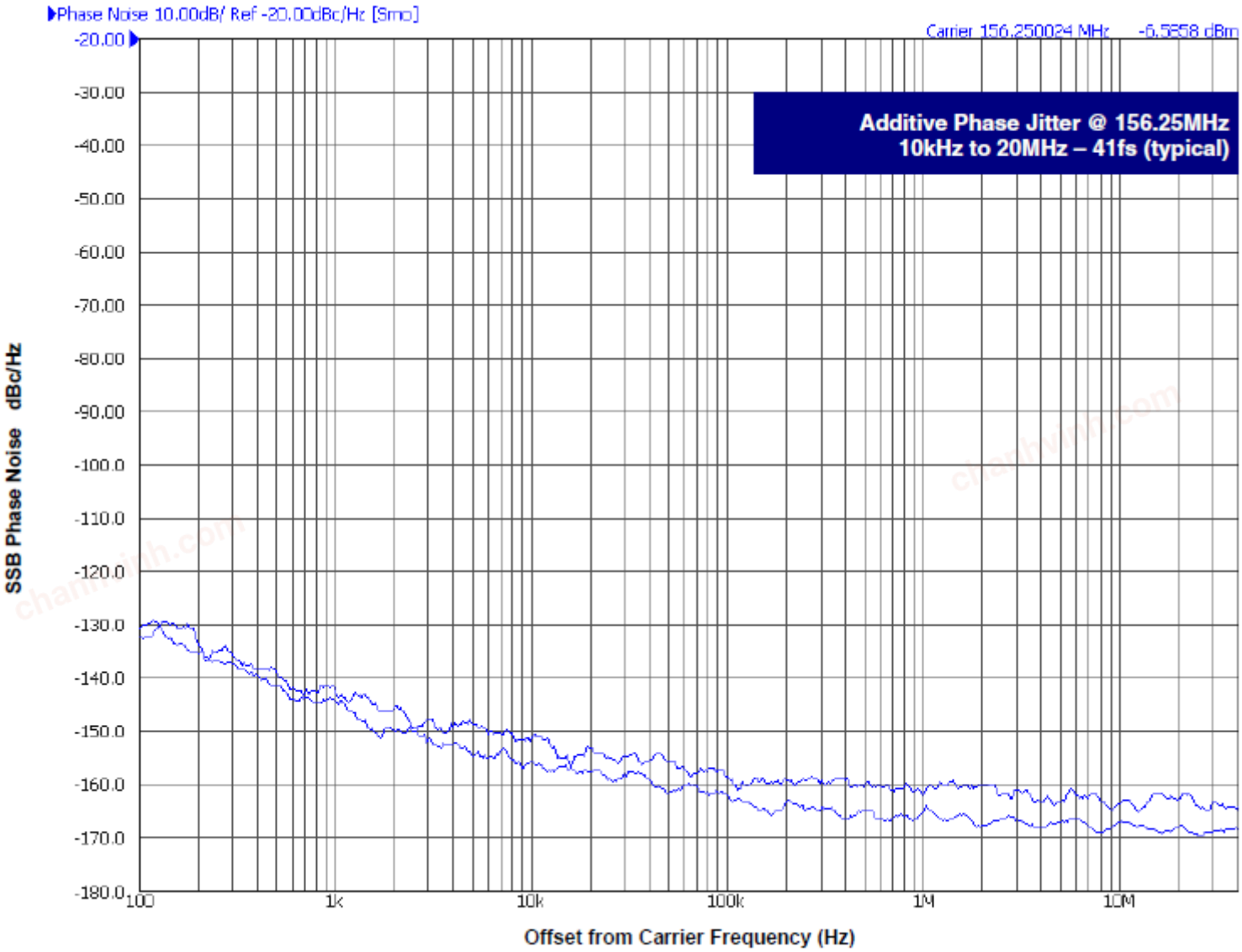
[f] Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Each device uses the same type of input.

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Additive Phase Jitter

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the ***dBc Phase Noise.*** This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental.

This ratio is expressed in decibels (dBm) or a ratio of the power in the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a ***dBc*** value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.

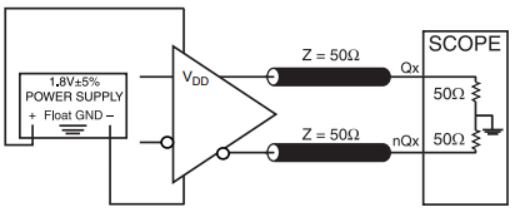


As with most timing specifications, phase noise measurements have issues relating to the limitations of the measurement equipment. The noise floor of the equipment can be higher or lower than the noise floor of the device. Additive phase noise is dependent on both the noise floor of the input source and measurement equipment.

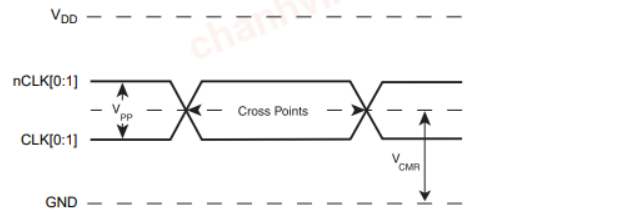
Measured using a Wenzel 156.25MHz Oscillator as the input source.

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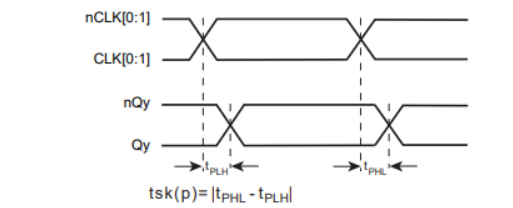
Parameter Measurement Information



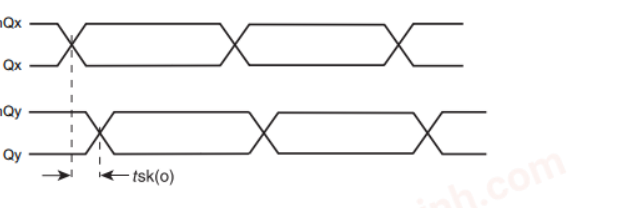
1.8V LVDS Output Load Test Circuit



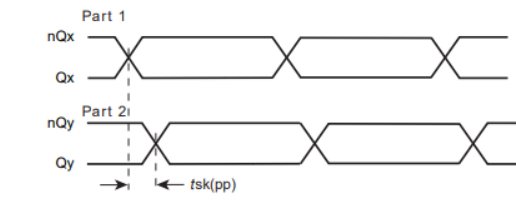
Differential Input Level



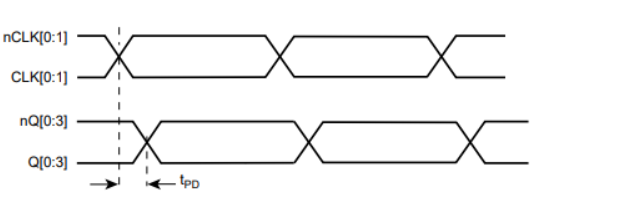
Pulse Skew



Output Skew

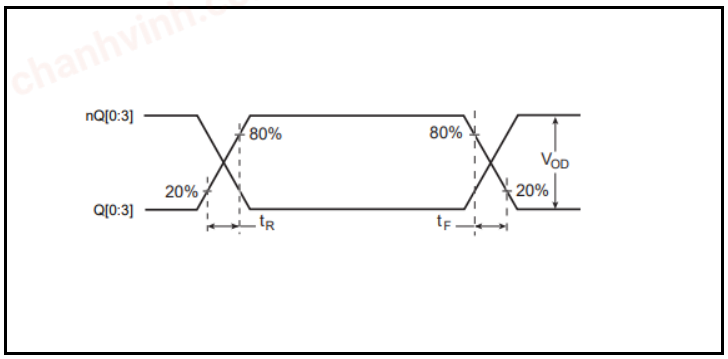


Part-to-Part Skew

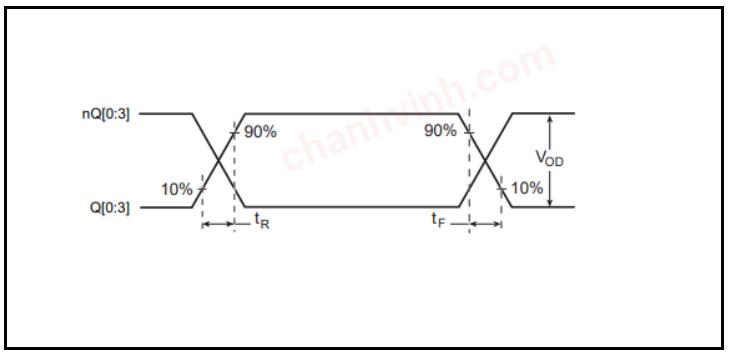


Propagation Delay

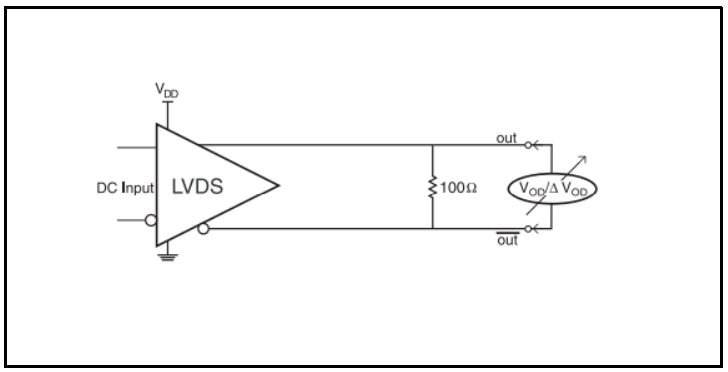
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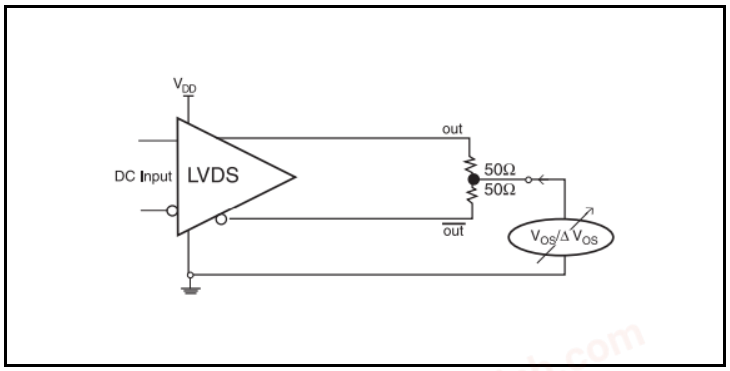
Output Rise/Fall Time, 20% – 80%



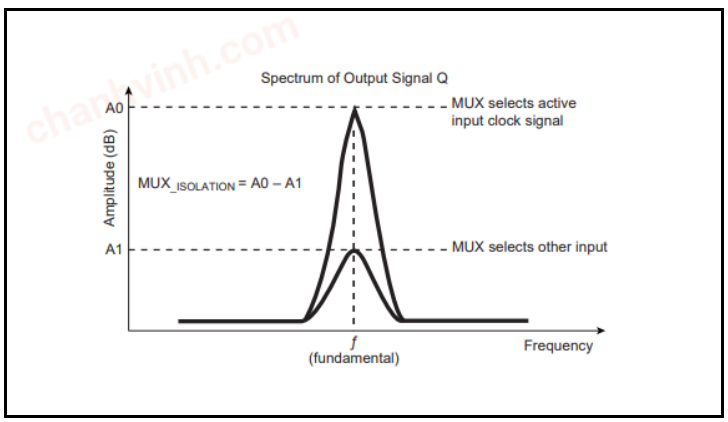
Output Rise/Fall Time, 10% – 90%



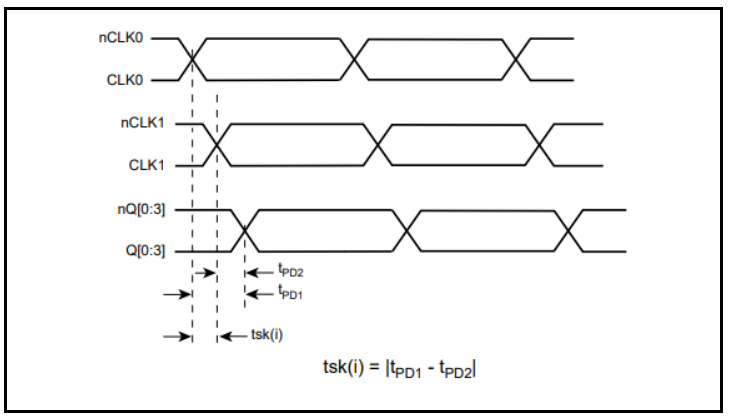
Differential Output Voltage Setup



Offset Voltage Setup



MUX Isolation



Input Skew

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Applications Information

Wiring the Differential Input to Accept Single-Ended Levels

Figure 1A and Figure 1B show examples of how a differential input can be wired to accept single-ended levels. The values below are for when both the single ended swing and VDD are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission line impedance and the signal DC offset after AC coupling should be equal to V1. For most Zo = 50Ω applications, R3 = 100Ω and R4 can be 100Ω.

By keeping the same R3/R4 ratio, the values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the input can handle larger amplitude signaling, it is recommended that the amplitude be reduced. For single-ended applications, the swing can be larger. Make sure the single-ended logic high and logic low signal operates within specification limit. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

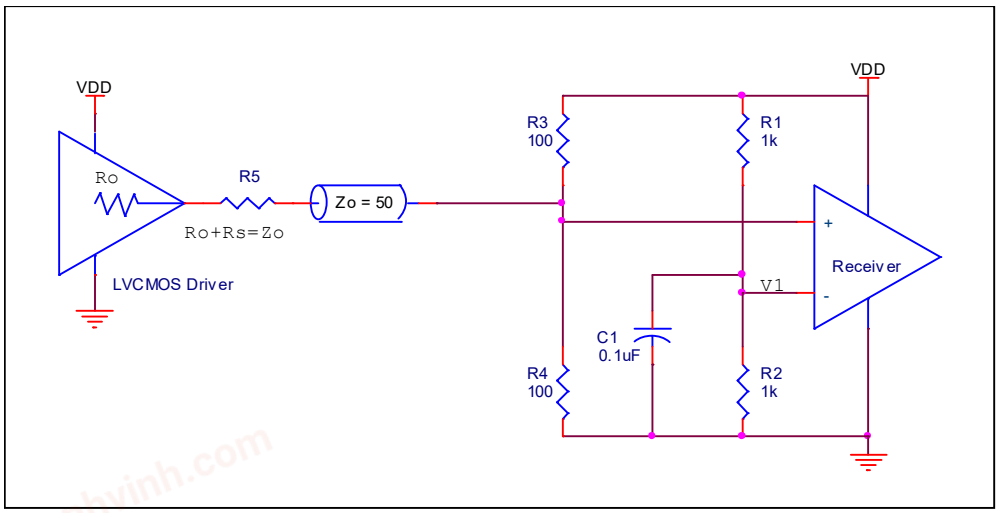


Figure 1A. DC Coupling Example for Wiring a Differential Input to Accept Single-ended Levels

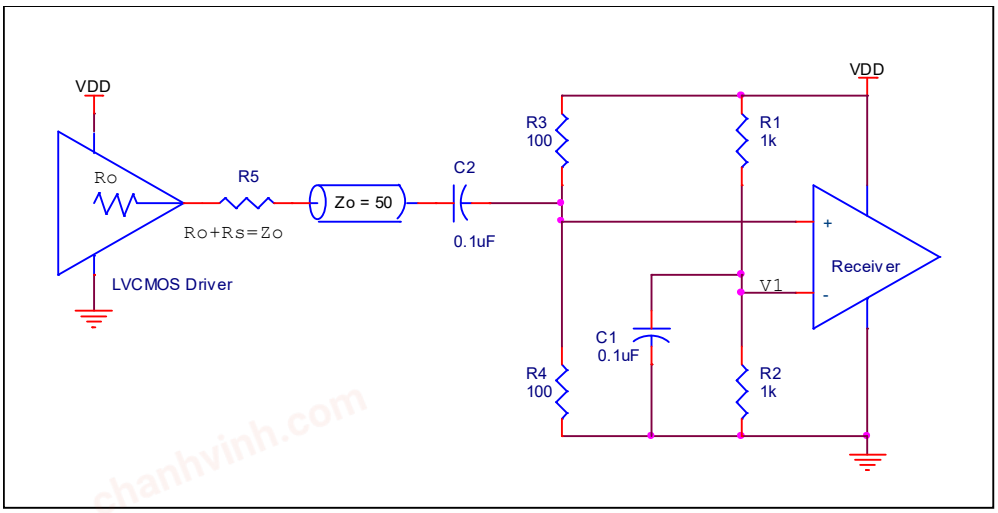


Figure 1B. AC Coupling Example for Wiring a Differential Input to Accept Single-ended Levels

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Recommendations for Unused Input and Output Pins

Inputs

CLK/nCLK Inputs

For applications not requiring the use of a differential input, both the CLK and nCLK pins can be left floating. Though not required, but for additional protection, a 1kΩ resistor can be tied from CLK to ground.

Outputs

LVDS Outputs

Unused LVDS outputs must either have a 100Ω differential termination or have a 100Ω pull-up resistor to VDD in order to ensure proper device operation

1.8V Differential Clock Input Interface

The CLK /nCLK accepts LVDS and other differential signals. The differential input signal must meet both the V_{PP} and V_{CMR} input requirements. *Figures 2A to 2D* show interface examples for the CLK /nCLK input driven by the most common driver types. The input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.

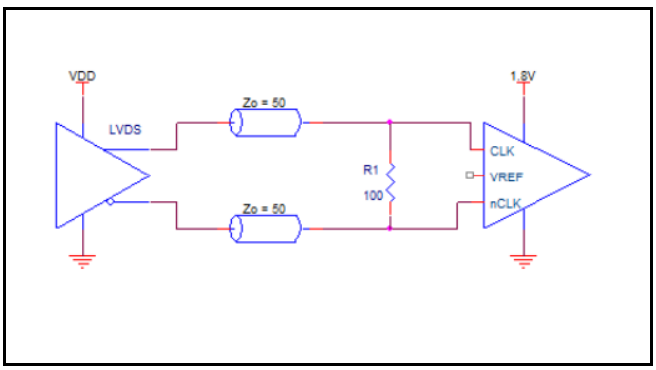


Figure 2A. Differential Input Driven by an LVDS Driver - DC Coupling

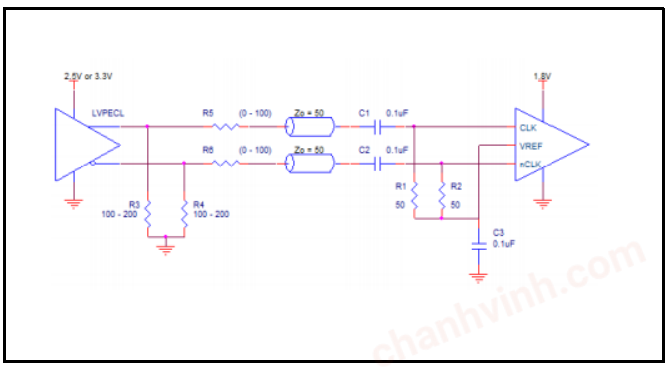


Figure 2B. Differential Input Driven by an LVPECL Driver - AC Coupling

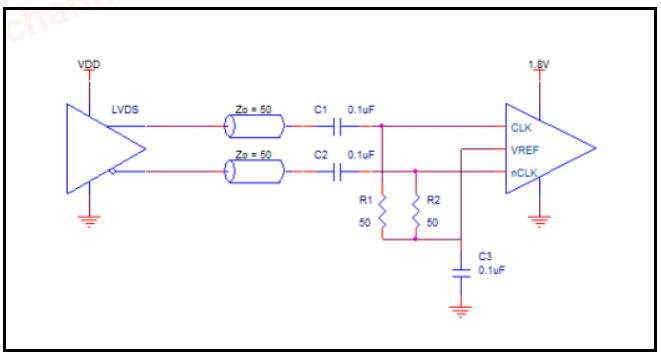


Figure 2C. Differential Input Driven by an LVDS Driver - AC Coupling

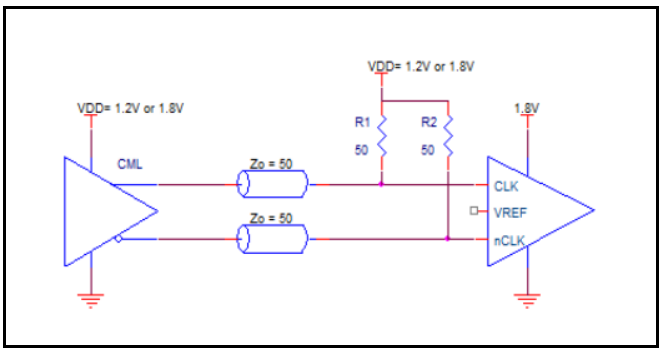
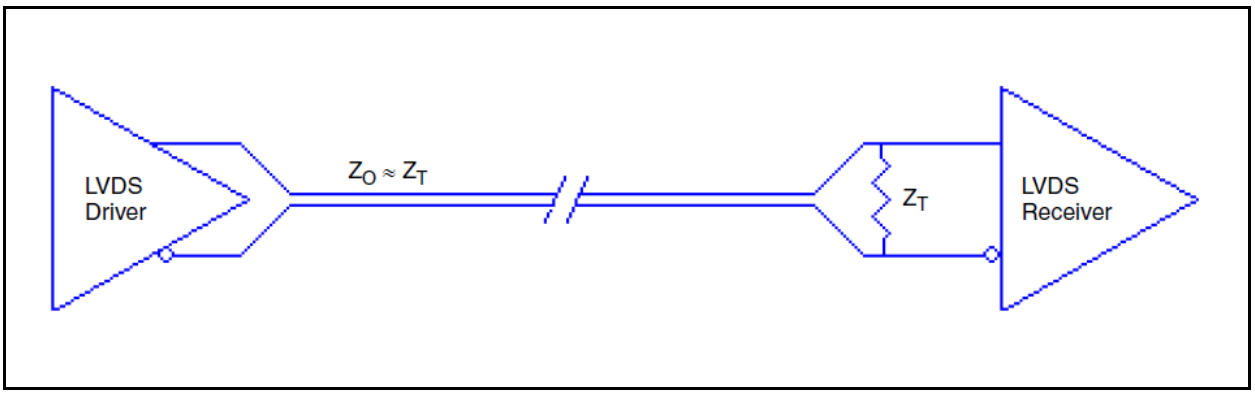


Figure 2D. Differential Input Driven by a CML Driver

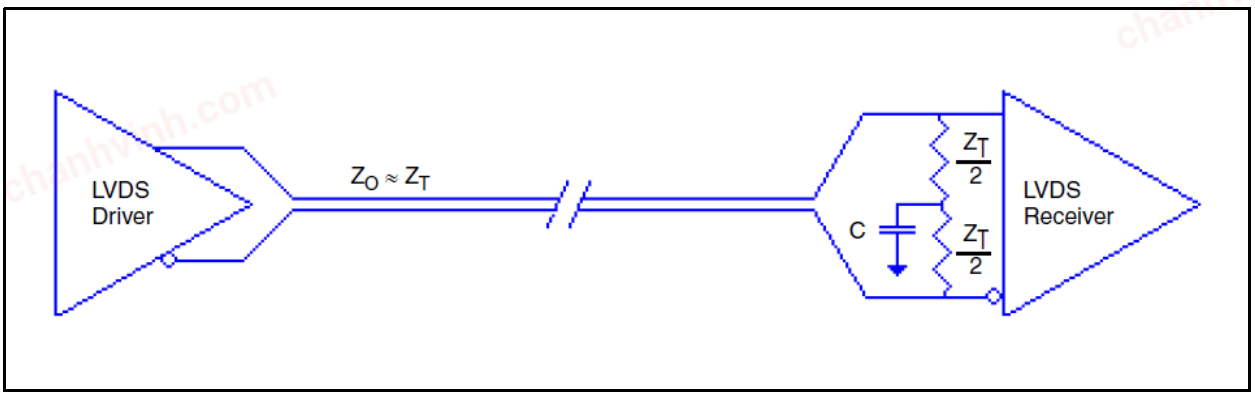
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LVDS Driver Termination

For a general LVDS interface, the recommended value for the termination impedance (Z_T) is between 90Ω and 132Ω. The actual value should be selected to match the differential impedance (Z_0) of your transmission line. A typical point-to-point LVDS design uses a 100Ω parallel resistor at the receiver and a 100Ω differential transmission-line environment. In order to avoid any transmission-line reflection issues, the components should be surface mounted and must be placed as close to the receiver as possible. Renesas offers a full line of LVDS compliant devices with two types of output structures: current source and voltage source. The standard termination schematic as shown in the first figure can be used with either type of output structure. The second figure, which can also be used with both output types, is an optional termination with center tap capacitance to help filter common mode noise. The capacitor value should be approximately 50pF. If using a non-standard termination, it is recommended to contact Renesas and confirm if the output structure is current source or voltage source type. In addition, since these outputs are LVDS compatible, the input receiver's amplitude and common-mode input range should be verified for compatibility with the output.



Standard LVDS Termination



Optional LVDS Termination

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VFQFN EPAD Thermal Release Path

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 4*. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as “heat pipes”. The number of vias (i.e. “heat pipes”) are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements.

Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor’s Thermally/ Electrically Enhance Leadframe Base Package, Amkor Technology.

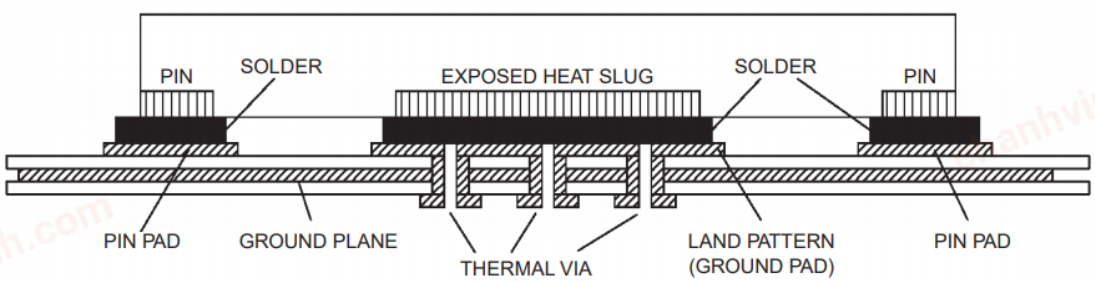


Figure 4. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale)

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Power Considerations

This section provides information on power dissipation and junction temperature for the 8P34S1208I. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the 8P34S1208I is the sum of the core power plus the output power dissipation due to the load. The following is the power dissipation for V_{DD} = 2.7V, which gives worst case results.

The maximum current at 85°C is as follows:

I_{DD_MAX} = 142mA

- Power $_{(core)MAX}$ = V_{DD_MAX} * I_{DD_MAX} = 2.7V * 142mA = **383.4mW**

Total Power$_{_MAX}$ = 383.4mW

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + TA

Tj = Junction Temperature

θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 46.2°C/W per Table 6 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

85°C + 0.383W * 46.2°C/W = 102.7°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 11. Thermal Resistance θ_{JA} for 28 Lead VFQFN

θ_{JA} at 0 Air Flow			
Meters per Second	**0**	**1**	**2**
Multi-Layer PCB, JEDEC Standard Test Boards	46.2°C/W	39.4C/W	37.1°C/W

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Reliability Information

Table 12. θ_{JA} vs. Air Flow Table for a 28 Lead VFQFN

θ_{JA} at 0 Air Flow			
Meters per Second	**0**	**1**	**2**
Multi-Layer PCB, JEDEC Standard Test Boards	46.2°C/W	39.4C/W	37.1°C/W

Transistor Count

The transistor count for the 8P34S1208 is: 976

Package Outline Drawings

The package outline drawings are located at the end of this document and are accessible from the Renesas website (see package links in Ordering Information). The package information is the most current data available and is subject to change without revision of this document.

Ordering Information

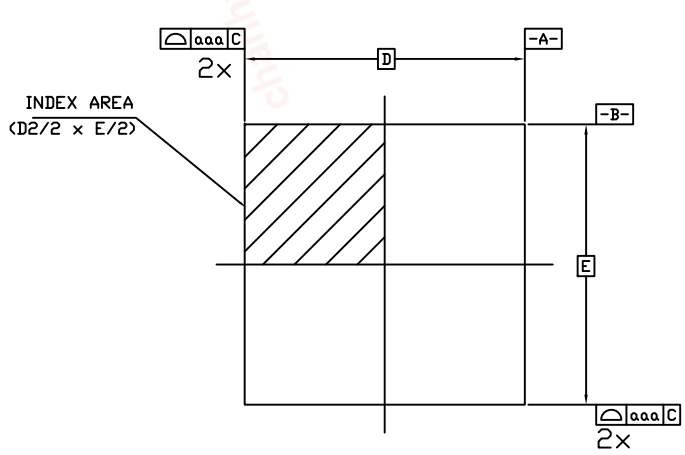
Table 13. Ordering Information

Part Number	Marking	Package	Carrier Type	Temperature Range
8P34S1208NBGI	P34S1208NBGI	Lead-Free 28-VFQFN	Tray	-40°C to 85°C
8P34S1208NBGI8	P34S1208NBGI	Lead-Free 28-VFQFN	Tape & Reel	-40°C to 85°C

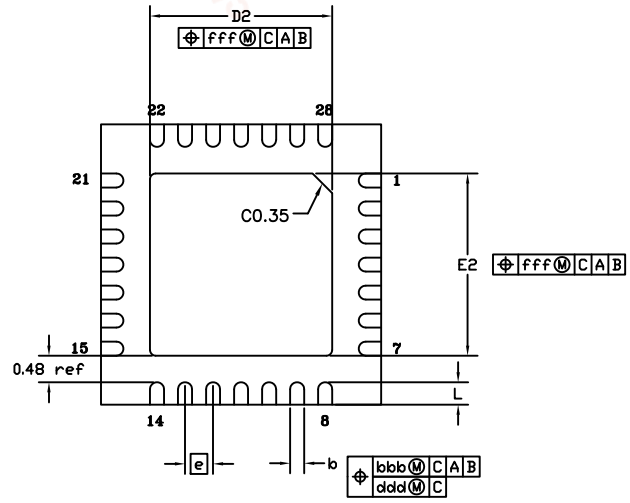
Revision History

Revision Date	Description of Change
August 30, 2021	Updated Features: ▪ Updated the “Maximum input clock frequency” bullet ▪ Changed the “Propagation delay” to be 400ps ▪ Added a bullet indicating support for “PCI Express Gen 1-5”
August 13, 2021	Updated Table 8.
August 5, 2021	▪ Updated DC Electrical Characteristics and AC Electrical Characteristics to support 2.5V operation ▪ Completed other minor changes
September 8, 2020	Updated the section “Wiring the Differential Input to Accept Single-Ended Levels”.
January 22, 2014	Initial release.

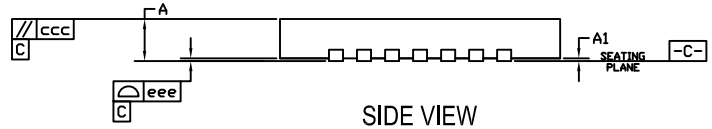
REVISIONS			
REV	DESCRIPTION	DATE	APPROVED
00	INITIAL RELEASE	06/04/10	KS
01	CORRECTION ON L	09/22/10	DP
02	COMBINE POD & LAND PATTERN	1/22/14	J.H



TOP VIEW



BOTTOM VIEW



SIDE VIEW

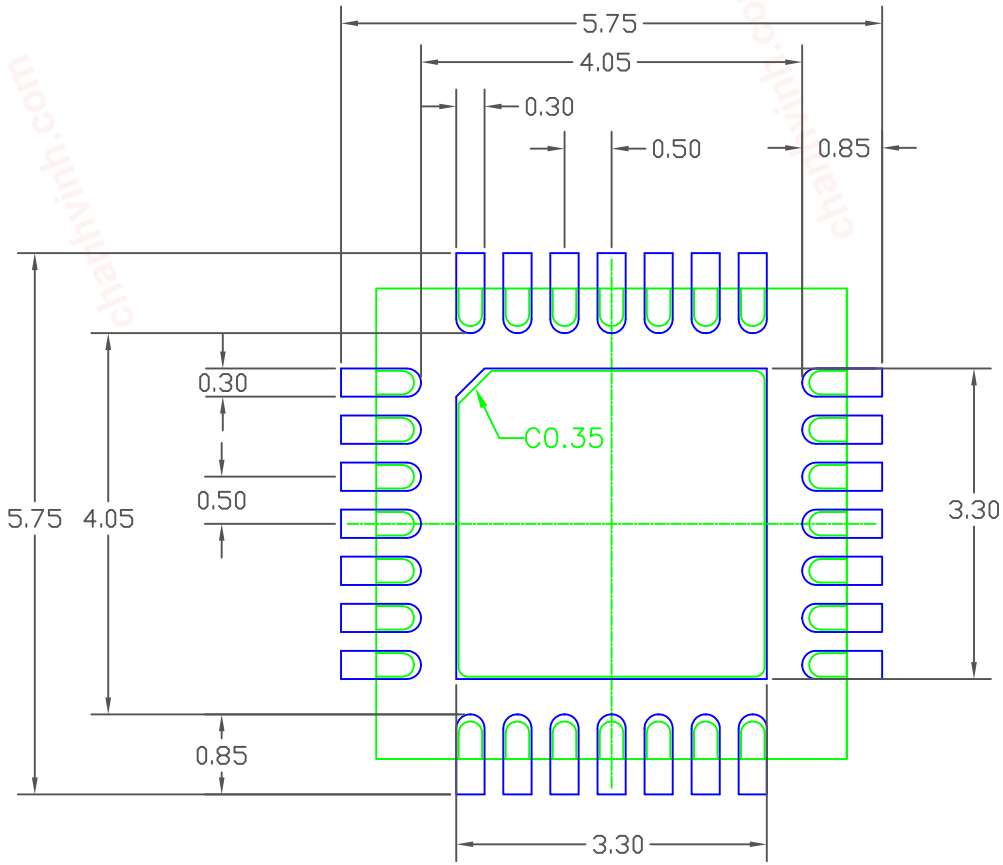
SYMBOL	DIMENSION		
	MIN	NOM	MAX
D2	3.15	3.25	3.35
E2	3.15	3.25	3.35
L	0.30	0.40	0.50
D		5.00 BSC	
E		5.00 BSC	
e		0.50 BSC	
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
b	.20	.25	.30
aaa		0.15	
bbb		0.10	
ccc		0.10	
ddd		0.05	
eee		0.08	
fff		0.10	

NOTES:

1. ALL DIMENSIONING AND TOLERANCING CONFORM TO ANSI Y14.5M–1982
2. ALL DIMENSIONS ARE IN MILLIMETERS.

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APPROVALS / DATE DRAWN 06/02/10 CHECKED	TITLE NB/NBG28 PACKAGE OUTLINE 5.0 x 5.0 mm BODY 0.50 mm PITCH QFN
	SIZE C / DRAWING No. PSC–4312 / REV 02
	DO NOT SCALE DRAWING / SHEET 1 OF 2

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REVISIONS			
REV	DESCRIPTION	DATE	APPROVED
00	INITIAL RELEASE	06/04/10	KS
01	CORRECTION ON L	09/22/10	DP
02	COMBINE POD & LAND PATTERN	1/22/14	J.H

NOTES:

1. ALL DIMENSION ARE IN mm. ANGLES IN DEGREES.
2. TOP DOWN VIEW. AS VIEWED ON PCB.
3. COMPONENT OUTLINE SHOW FOR REFERENCE IN GREEN.
4. LAND PATTERN IN BLUE. NSMD PATTERN ASSUMED.
5. LAND PATTERN RECOMMENDATION PER IPC-7351B GENERIC REQUIREMENT FOR SURFACE MOUNT DESIGN AND LAND PATTERN.

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DRAWN	06/02/10		
CHECKED			
		SIZE C	DRAWING No. PSC-4312 REV 02
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(Rev.1.0 Mar 2020)

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